

**Search Notes**

Application/Control No.

10/072,404

Examiner

Len Tran

Applicant(s)/Patent under  
Reexamination

STEEN, PAUL H.

Art Unit

1725

**SEARCHED**

Class	Subclass	Date	Examiner
164	463, 423	2/14/2006	LT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
164	all above	2/14/2006	LT
interference search attached printout		2/14/2006	LT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR